

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination	
			10/707,096	DEWANJEE ET AL.	
Examiner			David Buttner	Art Unit	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,787,626	09-2004	Dewanjee, Pijush K.	528/64
	B	US-6,762,273	07-2004	Dewanjee, Pijush K.	528/64
	C	US-2004/0106748	06-2004	Cuples et al.	525/453
	D	US-6,435,986	08-2002	Wu et al.	473/378
	E	US-4,709,003	11-1987	Scott et al.	528/60
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Chemical Abstract registry number 5285-60-9
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.